

REFERENCE DESIGNATION U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
WFK	6,465,325	10/15/02	Ridley et al.		

FOREIGN PATENT DOCUMENTS

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1	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
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* Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

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Rev. 10/94 (Form 3.6	05)	· · · · · · · · · · · · · · · · · · ·

REFERENCE DESIGNATION

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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
WFR	6,469,345 (Corresponding to JP-A-2001- 196587 which is discussed in page I of the spec.)	Oct. 22, 2002	Aoki et al.		
₩ FK	6,455,378 (Corresponding to JP-A-2001-127072 and JP-A-2001-127284 that are discussed in page 1 of the spec.)	Sep. 24, 2002	Inagawa et al.		
WFK	6,630,389 (Corresponding to JP-A-2002- 231945)	Oct. 7, 2003	Shibata et al.		

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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

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William F. Krien	DATE CONSIDERED / 3 / 06
Rev. 10/94 (Form 3.05)	